Determination of Reliable Grain Boundary Orientation using Automated Crystallographic Orientation Mapping in the Transmission Electron Microscope

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Precession assisted automated crystallographic orientation mapping (PA-ACOM) in TEM allows automated collection and indexing of electron nanodiffraction patterns from an area scanned by the electron beam. Acquisition and subsequent indexing of a large number of diffraction patterns obtained from the scanned area provides capabilities to generate orientation maps similar to electron backscattered diffraction. PA-ACOM bears significant advantages over equivalent scanning electron microscopy techniques for the determination of grain boundary orientations in nanogranular materials due to the fact that orientation is determined using transmission electron diffraction rather than backscattered Kikuchi patterns. This study demonstrates quantitatively that the compensation of second order aberrations introduced by high-angle precession of the electron beam is critical for the reliable determination of grain boundary orientations.

Two different types of materials were investigated to evaluate PA-ACOM based grain boundary analysis: a polycrystalline MgAl₂O₄ ceramic and a 5083 aluminum alloy composite. Nanocrystalline MgAl₂O₄ with a final average grain size of 150nm was isothermally sintered at 1300 °C for 40 minutes in air. The 5083 aluminum alloy composite, consisting of coarse-grained aluminum (grain size 600-2600 nm) and ultrafine grained 5083 aluminum (average grain size around 200 nm), was fabricated via cryomilling and subsequent hot isostatic pressing. More details regarding the synthesis of these two different types of materials are described elsewhere [1–3].

Table 1 summarizes average confidence indices (*CI*) for orientation maps obtained from both materials. The data for MgAl₂O₄ demonstrate that compensation of aberrations through the alignment procedures for beam precession improves confidence indices during ACOM. Highest average *CI* values are obtained using the 'full matching' procedure for data analysis. Although it was expected that smallest *CI* values are obtained without beam precession, the lowest average *CI* value was observed for experiments with misaligned beam precession and subsequent analysis using the 'fast matching' procedure, i.e. only a subset of diffraction pattern templates was considered for automated indexing [4]. ACOM is sensitive to accurate template matching, and improper compensation of lens aberrations that result from beam precession can lead to less reliable results than data obtained in the absence of precession. To illustrate the effects of precession alignment on grain boundary analysis, *CI* data across a single grain boundary were plotted in Fig.1. While with and without aberration compensation a confidence index of 20 was obtained at the center of the grain boundary, the improper alignment led to lower confidence indices extending at least 40 nm in each direction. After proper alignment, however, confidence indices only dropped significantly within 10 nm of each side of the grain boundary core.

Reference

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Table 1 – Average CI values for CI maps for each scan performed under the three conditions: no precession, precession not aligned, and precession aligned. [4]

	Properly Aligned with Precession	Not Aligned with Precession	No Precession
MgAl ₂ O ₄ Spinel	26.8 ± 20.6	'fast Match': 18.3 ± 17.9 'full match': 25.4 ± 20.9	21.5 ± 20.5
5083 Aluminum Alloy	'fast Match': 46.6 ± 23.5 'full match': 46.5 ± 22.6	24.6 ± 17.8	33.3 ± 21.1



Fig.1 The histogram shows *CI* values for an intensity line scan of a grain boundary with precession on but not aligned (black line), and aligned (red line). Reproduced with permission form [4].